IRF9540, IRF9541, IRF9542, IRF9543, RF1S9540, RF1S9540SM

Absolute Maximum Ratings $T_C = 25^{\circ}C$, Unless Otherwise Specified

UNITS	
V	
V	
Α	
Α	
Α	
V	
W	
W/oC	
mJ	
°C	
oC	
°C	
	A A V W W/°C mJ °C

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

NOTE:

1. $T_J = 25^{\circ}C$ to $150^{\circ}C$.

Electrical Specifications $T_C = 25^{\circ}C$, Unless Otherwise Specified

PARAMETER	SYMBOL	TEST CONDITIONS		TYP	MAX	UNITS
Drain to Source Breakdown Voltage IRF9540, IRF9542, RF1S9540, RF1S9540SM	BV _{DSS}	I_D = -250μA, V_{GS} = 0V (Figure 10)		-	-	٧
IRF9541, IRF9543				-	-	٧
Gate to Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D = -250 \mu A$	-2	-	-4	٧
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = Rated BV _{DSS} , V _{GS} = 0V	25		-25	μΑ
		$V_{DS} = 0.8 \text{ x Rated BV}_{DSS}, V_{GS} = 0V$ $T_C = 125^{\circ}C$		-	-250	μА
On-State Drain Current (Note 2) IRF9540, IRF9541, RF1S9540, RF1S9540SM	I _{D(ON)}	$V_{DS} > I_{D(ON)} \times r_{DS(ON)} MAX, V_{GS} = -10V$		-	-	Α
IRF9542, IRF9543				-	-	Α
Gate to Source Leakage Current	I _{GSS}	V _{GS} = ±20V	-	-	±100	nA
Drain to Source On Resistance (Note 2) IRF9540, IRF9541, RF1S9540, RF1S9540SM	r _{DS(ON)}	I _D = -10A, V _{GS} = -10V (Figures 8, 9)		0.15	0.20	Ω
IRF9542, IRF9543				0.22	0.30	Ω
Forward Transconductance (Note 2)	9fs	V _{DS} > I _{D(ON)} x r _{DS(ON)} MAX, I _D = -6A (Figure 12)		7	-	s
Turn-On Delay Time	t _{d(ON)}	$\begin{split} &V_{DD}=\text{-}50\text{V}, \text{ I}_{D}\approx \text{19A}, \text{ R}_{G}=9.1\Omega, \text{ R}_{L}=2.3\Omega, \\ &V_{GS}=\text{-}10\text{V}, \text{ (Figures 17, 18)} \\ &\text{MOSFET Switching Times are Essentially} \\ &\text{Independent of Operating Temperature} \end{split}$		16	20	ns
Rise Time	t _r			65	100	ns
Turn-Off Delay Time	t _{d(OFF)}			47	70	ns
Fall Time	t _f			28	70	ns
Total Gate Charge (Gate to Source + Gate to Drain)	Q _{g(TOT)}	V_{GS} = -10V, I_D = -19A, V_{DS} = 0.8 x Rated BV _{DSS} , $I_{g(REF)}$ = -1.5mA (Figures 14, 19, 20) Gate Charge is Essentially Independent of Operating Temperature		70	90	nC
Gate to Source Charge	Q _{gs}			14	-	пC
Gate to Drain "Miller" Charge	Q _{gd}		-	56	-	пC

IRF9540, IRF9541, IRF9542, IRF9543, RF1S9540, RF1S9540SM

Electrical Specifications $T_C = 25^{\circ}C$, Unless Otherwise Specified (Continued)

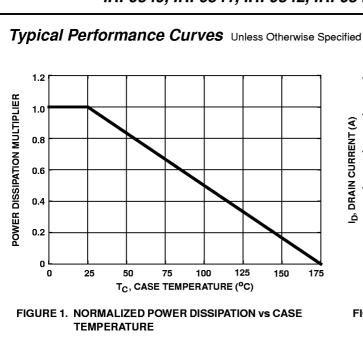
PARAMETER	SYMBOL	TEST CONDITIONS		MIN	TYP	MAX	UNITS
Input Capacitance	C _{ISS}	$V_{DS} = -25V, V_{GS} = 0V, f = 1MHz$		-	1100	-	pF
Output Capacitance	C _{OSS}	(Figure 11)	(Figure 11)		550	-	pF
Reverse Transfer Capacitance	C _{RSS}				250	-	pF
Internal Drain Inductance	L _D	Measured From the Contact Screw on Tab to the Center of Die	Modified MOSFET Symbol Showing the Internal Devices	-	3.5	-	nH
		Measured From the Drain Lead, 6mm (0.25in) from Package to the Center of Die	Inductances D ELD	-	4.5	-	nH
Internal Source Inductance	LS	Measured From the Source Lead, 6mm (0.25in) From Package to Source Bonding Pad	G ELS	-	7.5	-	nH
Thermal Resistance Junction to Case	$R_{ heta JC}$			-	-	1	°C/W
Thermal Resistance Junction to Ambient	$R_{\theta JA}$	Typical Socket Mount		-	-	62.5	°C/W

Source to Drain Diode Specifications

PARAMETER	SYMBOL	TEST CONDITIONS		MIN	TYP	MAX	UNITS
Continuous Source to Drain Current	I _{SD}	Modified MOSFET Sym-	• D	·	ı	-19	Α
Pulse Source to Drain Current (Note 3)	^I SDM	bol Showing the Integral Reverse P-N Junction Diode	G S	-	-	-76	A
Source to Drain Diode Voltage (Note 2)	V_{SD}	$T_C = 25^{\circ}C$, $I_{SD} = -19A$, $V_{GS} = 0V$ (Figure 13)		i	ı	-1.5	٧
Reverse Recovery Time	t _{rr}	$T_J = 150^{o}C$, $I_{SD} = 19A$, $dI_{SD}/dt = 100A/\mu s$		-	170	ı	ns
Reverse Recovery Charge	Q _{RR}	$T_J = 150^{o}C$, $I_{SD} = 19A$, $dI_{SD}/dt = 100A/\mu s$		-	0.8	-	μC

NOTES:

- 2. Pulse test: pulse width $\leq 300 \mu s,$ duty cycle $\leq 2\%.$
- 3. Repetitive rating: pulse width limited by maximum junction temperature. See Transient Thermal Impedance curve (Figure 3).
- 4. V_{DD} = 25V, starting T_J = 25°C, L = 4mH, R_G = 25 Ω , peak I_{AS} = 19A. (Figures 15, 16).



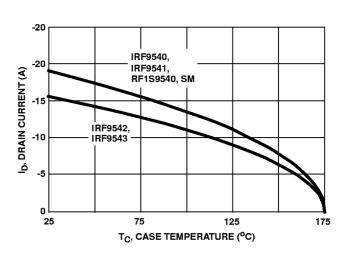


FIGURE 2. MAXIMUM CONTINUOUS DRAIN CURRENT vs **CASE TEMPERATURE**

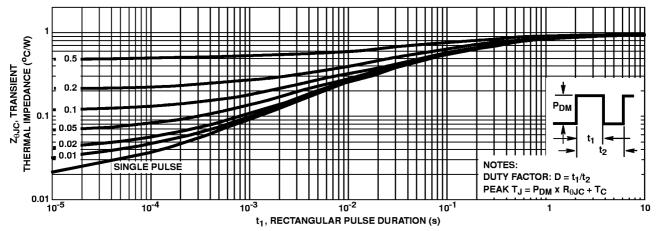
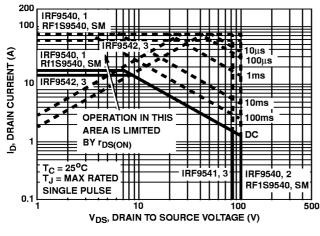


FIGURE 3. NORMALIZED MAXIMUM TRANSIENT THERMAL IMPEDANCE

-100



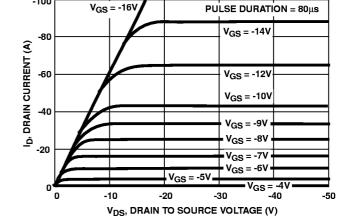
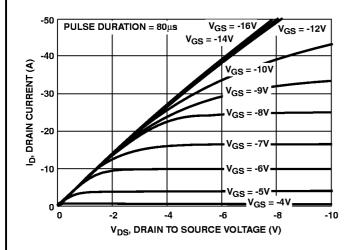


FIGURE 4. FORWARD BIAS SAFE OPERATING AREA

FIGURE 5. OUTPUT CHARACTERISTICS

Typical Performance Curves Unless Otherwise Specified (Continued)



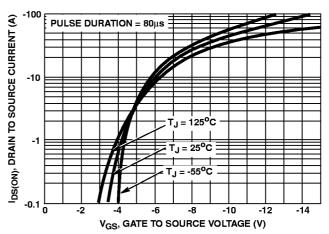
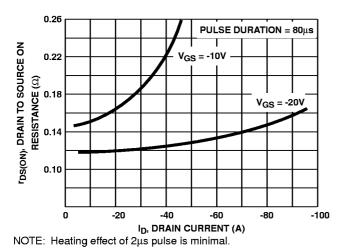


FIGURE 6. SATURATION CHARACTERISTICS

FIGURE 7. TRANSFER CHARACTERISTICS



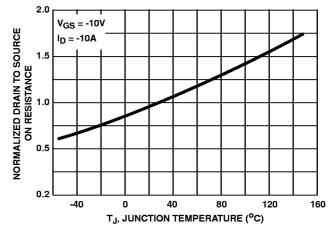
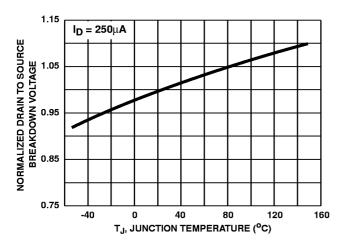


FIGURE 8. DRAIN TO SOURCE ON RESISTANCE VS GATE VOLTAGE AND DRAIN CURRENT

FIGURE 9. NORMALIZED DRAIN TO SOURCE ON RESISTANCE vs JUNCTION TEMPERATURE



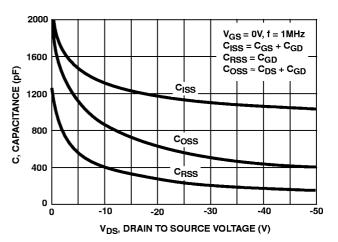
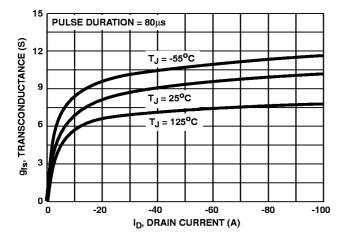


FIGURE 10. NORMALIZED DRAIN TO SOURCE BREAKDOWN VOLTAGE vs JUNCTION TEMPERATURE

FIGURE 11. CAPACITANCE vs DRAIN TO SOURCE VOLTAGE

Typical Performance Curves Unless Otherwise Specified (Continued)



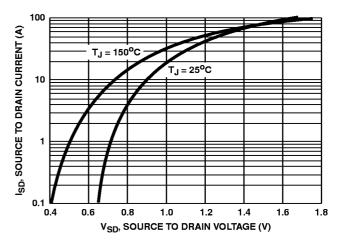


FIGURE 12. TRANSCONDUCTANCE vs DRAIN CURRENT

FIGURE 13. SOURCE TO DRAIN DIODE VOLTAGE

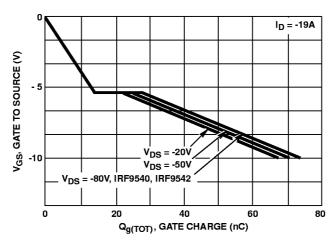


FIGURE 14. GATE TO SOURCE VOLTAGE vs GATE CHARGE

Test Circuits and Waveforms

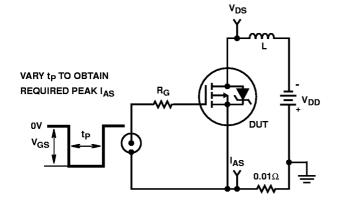


FIGURE 15. UNCLAMPED ENERGY TEST CIRCUIT

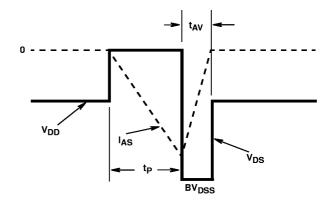


FIGURE 16. UNCLAMPED ENERGY WAVEFORMS

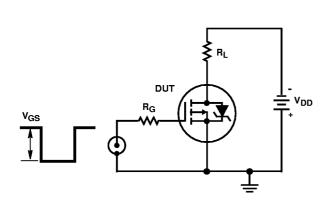


FIGURE 17. SWITCHING TIME TEST CIRCUIT

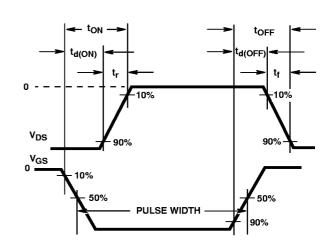


FIGURE 18. RESISTIVE SWITCHING WAVEFORMS

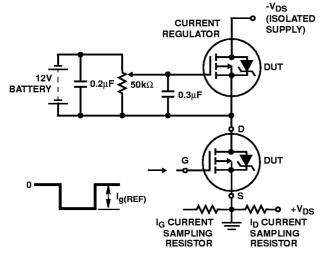


FIGURE 19. GATE CHARGE TEST CIRCUIT

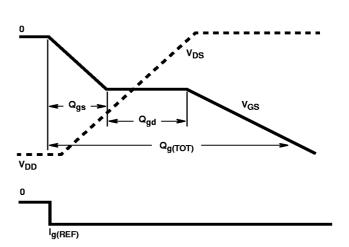


FIGURE 20. GATE CHARGE WAVEFORMS

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